## TELECOMMUNICATION SYSTEM SECONDARY PROTECTION

## Patented Ion-Implanted Breakdown Region Precise DC and Dynamic Voltages

DEVICE	V <sub>DRM</sub>	V <sub>(BO)</sub>
BEVICE	v	v
'7125F3	100	125
'7150F3	120	150
'7180F3	145	180
'7240F3	180	240
'7260F3	200	260
'7290F3	220	290
'7320F3	240	320
'7350F3	275	350
'7380F3†	270	380

† For new designs use '7350F3 instead of '7380F3

- Planar Passivated Junctions
   Low Off-State Current .....< 10 μA</li>
- Rated for International Surge Wave Shapes
   Single and Simultaneous Impulses

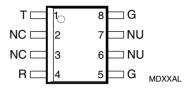
WAVE SHAPE	STANDARD	I <sub>TSP</sub> A	
2/10	GR-1089-CORE	190	
8/20	IEC 61000-4-5	175	
10/160	FCC Part 68	110	
10/700	FCC Part 68	70	
10/100	ITU-T K.20/21	70	
10/560	FCC Part 68	50	
10/1000	GR-1089-CORE	45	



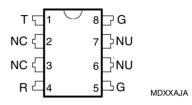
## description

The TISP7xxxF3 series are 3-point overvoltage protectors designed for protecting against metallic (differential mode) and simultaneous longitudinal (common mode) surges. Each terminal pair has the same voltage limiting values and surge current capability. This terminal pair surge capability ensures that the protector can meet the simultaneous longitudinal surge requirement which is typically twice the metallic surge requirement.

#### D PACKAGE (TOP VIEW)



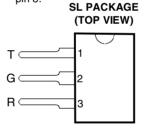
#### P PACKAGE (TOP VIEW)



NC - No internal connection

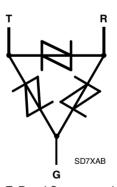
NU - Nonusable; no external electrical connection should be made to these pins.

Specified ratings require connection of pin 5 and pin 8.



MDXXAGA MD7XAACA

## device symbol



Terminals T, R and G correspond to the alternative line designators of A, B and C

## AVAILABLE OPTIONS

DEVICE	PACKAGE	CARRIER	ORDER #
TISP7xxxF3 D, Small-outline		TAPE AND REEL	TISP7xxxF3DR
1101 7 7 7 7 7	D, Omair oddine	TUBE	TISP7xxxF3D
TISP7xxxF3	P, Plastic DIP	TUBE	TISP7xxxF3P
TISP7xxxF3	TISP7xxxF3 SL, Single-in-line		TISP7xxxF3SL



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#### description (continued)

Each terminal pair has a symmetrical voltage-triggered thyristor characteristic. Overvoltages are initially clipped by breakdown clamping until the voltage rises to the breakover level, which causes the device to crowbar into a low-voltage on state. This low-voltage on state causes the current resulting from the overvoltage to be safely diverted through the device. The high crowbar holding current prevents d.c. latchup as the diverted current subsides. These protectors are guaranteed to voltage limit and withstand the listed lightning surges in both polarities.

These medium and high voltage devices are offered in nine voltage variants to meet a range battery and ringing voltage requirements. They are guaranteed to suppress and withstand the listed international lightning surges on any terminal pair. Similar devices with working voltages of 58 V and 66 V are detailed in the TISP7072F3, TISP7082F3 data sheet.

## absolute maximum ratings, T<sub>A</sub> = 25 °C (unless otherwise noted)

RATING		SYMBOL	VALUE	UNIT
Repetitive peak off-state voltage, 0 °C < T <sub>A</sub> < 70 °C				
	'7125F3		100	
	'7150F3		120	
	'7180F3		145	V
	'7240F3	$V_{DRM}$	180	
	'7260F3	DHM	200	•
	'7290F3		220	
	'7320F3		240	
	'7350F3		275	
	'7380F3		270	
Non-repetitive peak on-state pulse current (see Notes 1 and 2)				
1/2 (Gas tube differential transient, 1/2 voltage wave shape)			330	
2/10 (Telcordia GR-1089-CORE, 2/10 voltage wave shape)		I	190	
1/20 (ITU-T K.22, 1.2/50 voltage wave shape, 25 $\Omega$ resistor)			100	
8/20 (IEC 61000-4-5, combination wave generator, 1.2/50 voltage wave	e shape)		175	۸
10/160 (FCC Part 68, 10/160 voltage wave shape)			110	
4/250 (ITU-T K.20/21, 10/700 voltage wave shape, simultaneous)		I <sub>PPSM</sub>	95	Α
0.2/310 (CNET I 31-24, 0.5/700 voltage wave shape)			70	
5/310 (ITU-T K.20/21, 10/700 voltage wave shape, single)			70	
5/320 (FCC Part 68, 9/720 voltage wave shape, single)			70	
10/560 (FCC Part 68, 10/560 voltage wave shape)			50	
10/1000 (Telcordia GR-1089-CORE, 10/1000 voltage wave shape)			45	
Non-repetitive peak on-state current, 0 °C < T <sub>A</sub> < 70 °C (see Notes 1 and 3)				
50 Hz, 1 s	D Package		4.3	
	P Package	$I_{TSM}$	5.7	Α
	SL Package		7.1	
Initial rate of rise of on-state current,  Linear current ramp, Maximum ramp value	nitial rate of rise of on-state current, Linear current ramp, Maximum ramp value < 38 A		250	A/µs
Junction temperature		T <sub>J</sub>	-65 to +150	°C
Storage temperature range		$T_{stg}$	-65 to +150	°C

- NOTES: 1. Initially the TISP® must be in thermal equilibrium at the specified T<sub>A</sub>. The surge may be repeated after the TISP® returns to its initial conditions. The rated current values may be applied singly either to the R to G or to the T to G or to the T to R terminals. Additionally, both R to G and T to G may have their rated current values applied simultaneously (In this case the total G terminal current will be twice the above rated current values).
  - 2. See Thermal Information for derated  $I_{PPSM}$  values 0 °C <  $T_A$  < 70 °C and Applications Information for details on wave shapes.
  - 3. Above 70 °C, derate I<sub>TSM</sub> linearly to zero at 150 °C lead temperature.

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## electrical characteristics for all terminal pairs, $T_A$ = 25 °C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
I <sub>DRM</sub>	Repetitive peak off- state current	V <sub>D</sub> = V <sub>DRM</sub> , 0 °C < T <sub>A</sub> < 70 °C				±10	μΑ
			'7125F3			±125	
			'7150F3			±150	
			'7180F3			±180	
			'7240F3			±240	
$V_{(BO)}$	Breakover voltage	$dv/dt = \pm 250 \text{ V/ms},  R_{SOURCE} = 300 \Omega$	'7260F3			±260	V
			'7290F3			±290	
			'7320F3			±320	
			'7350F3			±350	
			'7380F3			±380	
			'7125F3			±143	
			'7150F3			±168	
		dulate < 1000 M/m Linear valtage ramp	'7180F3			±198	
	Impulse breekers	dv/dt ≤ ±1000 V/μs, Linear voltage ramp,	'7240F3			±269	
$V_{(BO)}$	Impulse breakover	Maximum ramp value = ±500 V	'7260F3			±289	V
	voltage	di/dt = ±20 A/μs, Linear current ramp,	'7290F3			±319	
		Maximum ramp value = ±10 A	'7320F3			±349	
			'7350F3			±379	
			'7380F3			±409	
I <sub>(BO)</sub>	Breakover current	$dv/dt = \pm 250 \text{ V/ms},  R_{SOURCE} = 300 \Omega$		±0.1		±0.8	Α
V <sub>T</sub>	On-state voltage	$I_T = \pm 5 \text{ A}, t_W = 100 \mu \text{s}$				±5	V
I <sub>H</sub>	Holding current	$I_T = \pm 5 \text{ A, di/dt} = +/-30 \text{ mA/ms}$		±0.15			Α
dv/dt	Critical rate of rise of off-state voltage	Linear voltage ramp, Maximum ramp value < 0.85V <sub>DRN</sub>	1	±5			kV/μs
I <sub>D</sub>	Off-state current	$V_D = \pm 50 \text{ V}$				±10	μΑ
		$f = 1 \text{ MHz},  V_d = 1 \text{ V rms}, V_D = 0$	'7125 thru '7180		37	48	
			'7240 thru '7380		31	41	
		$f = 1 \text{ MHz},  V_d = 1 \text{ V rms}, V_D = -1 \text{ V}$	'7125 thru '7180		40	52	
			'7240 thru '7380		34	44	
		$f = 1 \text{ MHz},  V_d = 1 \text{ V rms}, V_D = -2 \text{ V}$	'7125 thru '7180		36	47	
			'7240 thru '7380		30	39	
C <sub>off</sub>	Off-state capacitance	$f = 1 \text{ MHz},  V_d = 1 \text{ V rms}, V_D = -5 \text{ V}$	'7125 thru '7180		31	40	pF
Ooff	On-State Capacitance		'7240 thru '7380		24	31	ρı
		$f = 1 \text{ MHz},  V_d = 1 \text{ V rms}, V_D = -50 \text{ V}$	'7125 thru '7180		17	23	
			'7240 thru '7380		13	17	
		$f = 1 \text{ MHz},  V_d = 1 \text{ V rms}, V_D = -100 \text{ V}$	'7125 thru '7180		14	18	
			'7240 thru '7380		10	13	
		$f = 1 \text{ MHz},  V_d = 1 \text{ V rms}, V_{DTR} = 0$	'7125 thru '7180		20	27	
		(see Note 4)	'7240 thru '7380		17	23	

NOTE 4: Three-terminal guarded measurement, unmeasured terminal voltage bias is zero. First six capacitance values, with bias V<sub>D</sub>, are for the R-G and T-G terminals only. The last capacitance value, with bias V<sub>DTR</sub>, is for the T-R terminals.



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#### thermal characteristics

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
		B -0.9 W T - 25°C	D Package			160	
R <sub>0JA</sub> Junction to free air thermal resistance	$P_{tot} = 0.8 \text{ W}, T_A = 25^{\circ}\text{C}$ 5 cm <sup>2</sup> , FR4 PCB	P Package			100	°C/W	
		S CIII , I THA I OB	SL Package			135	

## PARAMETER MEASUREMENT INFORMATION

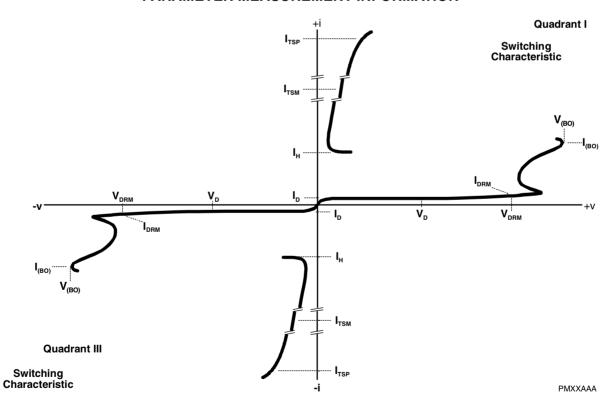


Figure 1. VOLTAGE-CURRENT CHARACTERISTIC FOR T AND R TERMINALS

T and G and R and G measurements are referenced to the G terminal

T and R measurements are referenced to the R terminal

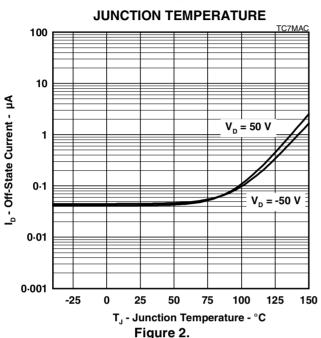
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## TYPICAL CHARACTERISTICS R and G, or T and G terminals

## **TISP7125F3 THRU TISP7180F3**

**OFF-STATE CURRENT** 

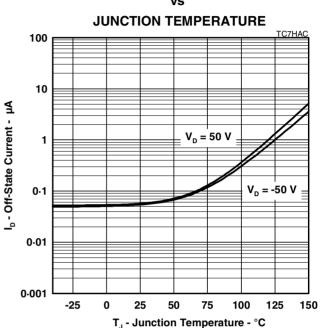
vs



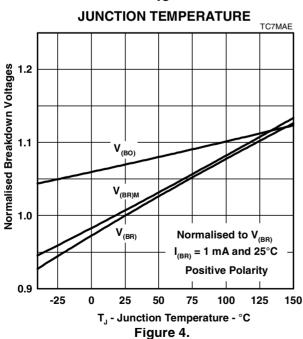
#### TISP7240F3 THRU TISP7380F3

**OFF-STATE CURRENT** 

vs

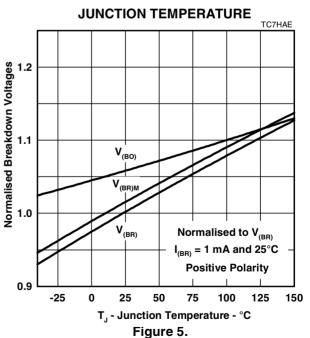


## NORMALISED BREAKDOWN VOLTAGES



## NORMALISED BREAKDOWN VOLTAGES

Figure 3.



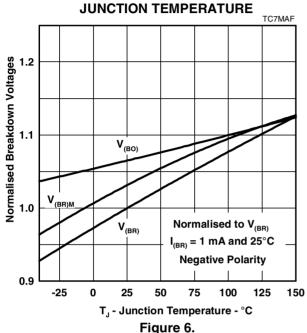


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## TYPICAL CHARACTERISTICS R and G, or T and G terminals

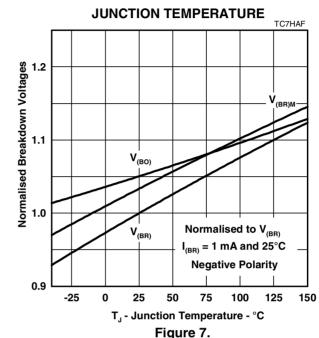
## TISP7125F3 THRU TISP7180F3 NORMALISED BREAKDOWN VOLTAGES

vs



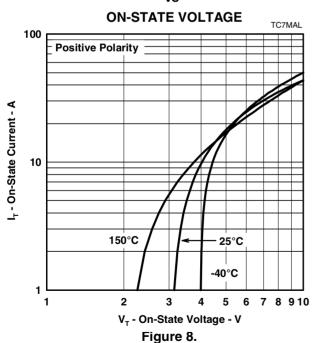
## TISP7240F3 THRU TISP7380F3 NORMALISED BREAKDOWN VOLTAGES

VS



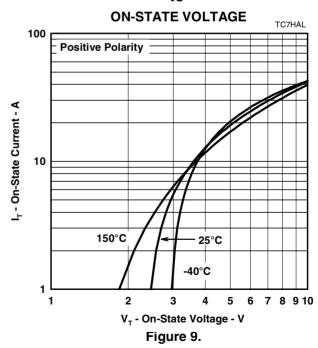
#### **ON-STATE CURRENT**

vs



## **ON-STATE CURRENT**

vs

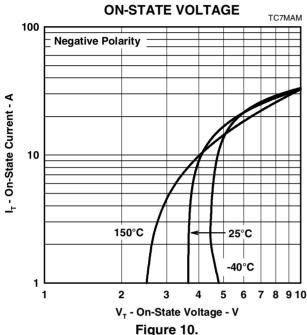


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## TYPICAL CHARACTERISTICS R and G, or T and G terminals

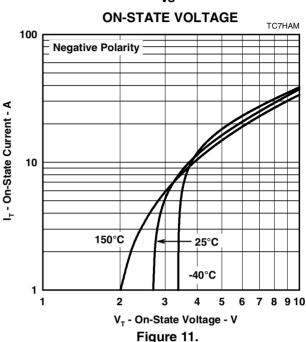
## TISP7125F3 THRU TISP7180F3 ON-STATE CURRENT

VS

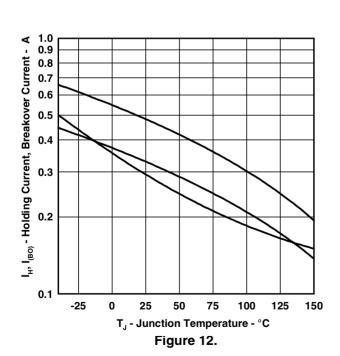


## TISP7240F3 THRU TISP7380F3 ON-STATE CURRENT

vs

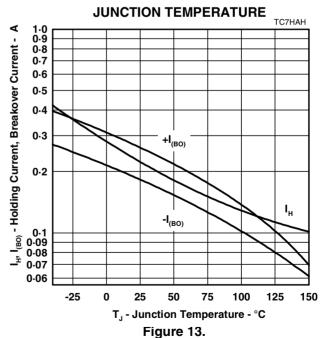


#### **HOLDING CURRENT & BREAKOVER CURRENT**



## **HOLDING CURRENT & BREAKOVER CURRENT**

vs

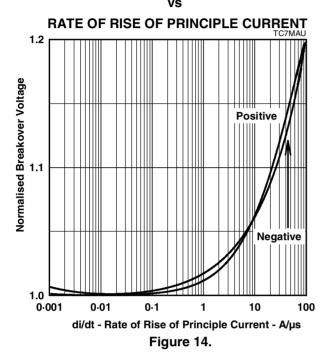




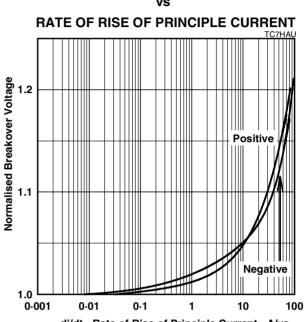
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## TYPICAL CHARACTERISTICS R and G, or T and G terminals

## TISP7125F3 THRU TISP7180F3 NORMALISED BREAKOVER VOLTAGE

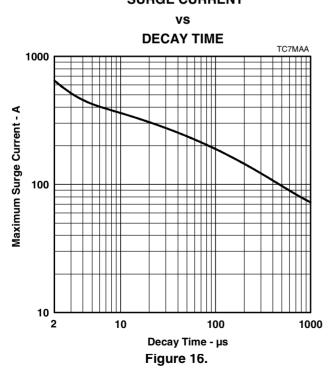


## TISP7240F3 THRU TISP7380F3 NORMALISED BREAKOVER VOLTAGE

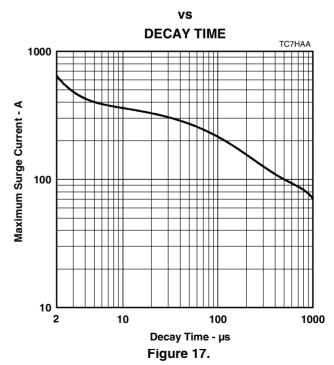


di/dt - Rate of Rise of Principle Current - A/μs Figure 15.

## **SURGE CURRENT**



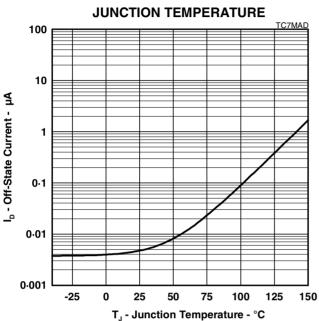
## **SURGE CURRENT**



## TYPICAL CHARACTERISTICS R and T terminals

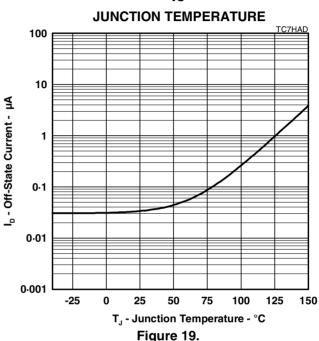
## TISP7125F3 THRU TISP7180F3 OFF-STATE CURRENT

vs



## TISP7240F3 THRU TISP7380F3 OFF-STATE CURRENT

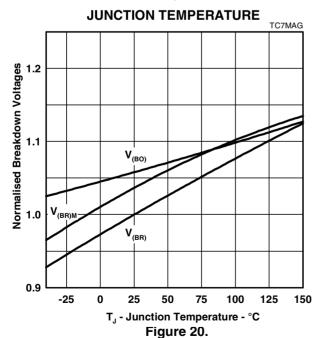
vs



## NORMALISED BREAKDOWN VOLTAGES

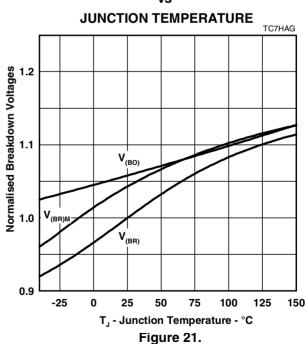
Figure 18.

vs



## NORMALISED BREAKDOWN VOLTAGES

VS





## TYPICAL CHARACTERISTICS R and T terminals

## TISP7125F3 THRU TISP7180F3 ON-STATE CURRENT

ON-STATE VOLTAGE

TC7MAK

100

4-tuano approximate to the state of the

## TISP7240F3 THRU TISP7380F3 ON-STATE CURRENT

ON-STATE VOLTAGE

TC7HAK

100

4 tuestrology
10

150°C

25°C

40°C

1

2

3

4

5

6

7

8

9

10

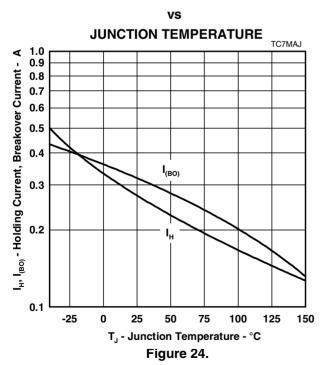
V<sub>T</sub> - On-State Voltage - V

Figure 23.

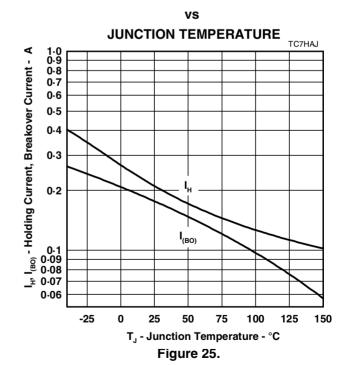
## **HOLDING CURRENT & BREAKOVER CURRENT**

V<sub>T</sub> - On-State Voltage - V

Figure 22.



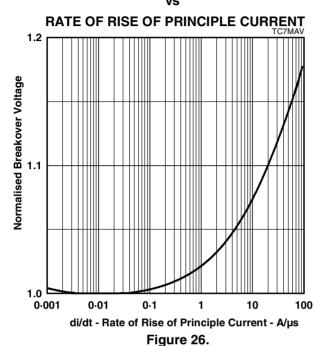
## **HOLDING CURRENT & BREAKOVER CURRENT**



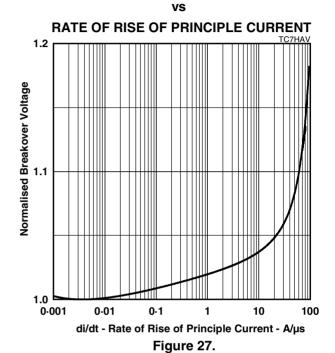
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## TYPICAL CHARACTERISTICS R and T terminals

# TISP7125F3 THRU TISP7180F3 NORMALISED BREAKOVER VOLTAGE vs



## TISP7240F3 THRU TISP7380F3 NORMALISED BREAKOVER VOLTAGE

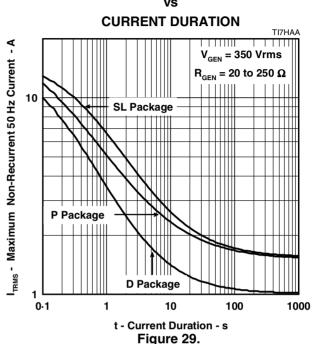


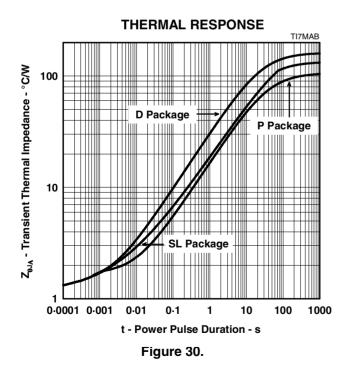
## THERMAL INFORMATION

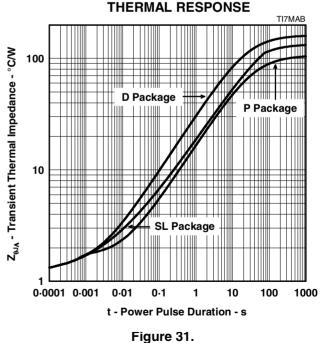
# TISP7125F3 THRU TISP7180F3 MAXIMUM NON-RECURRING 50 Hz CURRENT vs

# CURRENT DURATION TI7MAA V GEN = 250 Vrms R GEN = 10 to 150 Ω P Package P Package D Package 1 0.1 1 10 100 1000 t - Current Duration - s Figure 28.

# TISP7240F3 THRU TISP7380F3 MAXIMUM NON-RECURRING 50 Hz CURRENT







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## THERMAL INFORMATION

## Non-repetitive peak on-state pulse derated values for 0 $^{\circ}$ C $\leq$ T<sub>A</sub> $\leq$ 70 $^{\circ}$ C

RATING	SYMBOL	VALUE	UNIT
Non-repetitive peak on-state pulse current, 0 $^{\circ}$ C < T <sub>A</sub> < 70 $^{\circ}$ C (see Notes 5, 6 and 7)			
1/2 (Gas tube differential transient, 1/2 voltage wave shape)		320	
2/10 (Telcordia GR-1089-CORE, 2/10 voltage wave shape)		175	
1/20 (ITU-T K.22, 1.2/50 voltage wave shape, 25 $\Omega$ resistor)		90	
8/20 (IEC 61000-4-5, combination wave generator, 1.2/50 voltage wave shape)		150	
10/160 (FCC Part 68, 10/160 voltage wave shape)		90	_
4/250 (ITU-T K.20/21, 10/700 voltage wave shape, dual)	<sup>I</sup> PPSM	70	A
0.2/310 (CNET I 31-24, 0.5/700 voltage wave shape)		65	
5/310 (ITU-T K.20/21, 10/700 voltage wave shape, single)		65	
5/320 (FCC Part 68, 9/720 voltage wave shape)		65	
10/560 (FCC Part 68, 10/560 voltage wave shape)		45	
10/1000 (Telcordia GR-1089-CORE, 10/1000 voltage wave shape)		40	

NOTES: 5. Initially the TISP<sup>®</sup> must be in thermal equilibrium at the specified T<sub>A</sub>. The impulse may be repeated after the TISP<sup>®</sup> returns to its initial conditions. The rated current values may be applied either to the R to G or to the T to G or to the T to R terminals. Additionally, both R to G and T to G may have their rated current values applied simultaneously (In this case the total G terminal current will be twice the above rated current values).

- 6. See Applications Information for details on wave shapes.
- 7. Above 70 °C, derate  $I_{\mbox{\footnotesize{PPSM}}}$  linearly to zero at 150 °C lead temperature.



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#### **APPLICATIONS INFORMATION**

## deployment

These devices are three terminal overvoltage protectors. They limit the voltage between three points in the circuit. Typically, this would be the two line conductors and protective ground (Figure 32).

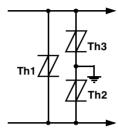


Figure 32. MULTI-POINT PROTECTION

In Figure 32, protectors Th2 and Th3 limit the maximum voltage between each conductor and ground to the  $\pm V_{(BO)}$  of the individual protector. Protector Th1 limits the maximum voltage between the two conductors to its  $\pm V_{(BO)}$  value.

## lightning surge

## wave shape notation

Most lightning tests, used for equipment verification, specify a unidirectional sawtooth waveform which has an exponential rise and an exponential decay. Wave shapes are classified in terms of rise time in microseconds and a decay time in microseconds to 50% of the maximum amplitude. The notation used for the wave shape is *rise time/decay time*, without the microseconds quantity and the "/" between the two values has no mathematical significance. A 50A, 5/310 waveform would have a peak current value of 50 A, a rise time of 5  $\mu$ s and a decay time of 310  $\mu$ s. The TISP<sup>®</sup> surge current graph comprehends the wave shapes of commonly used surges.

#### generators

There are three categories of surge generator type: single wave shape, combination wave shape and circuit defined. Single wave shape generators have essentially the same wave shape for the open circuit voltage and short circuit current (e.g. 10/1000 open circuit voltage and short circuit current). Combination generators have two wave shapes, one for the open circuit voltage and the other for the short circuit current (e.g. 1.2/50 open circuit voltage and 8/20 short circuit current) Circuit specified generators usually equate to a combination generator, although typically only the open circuit voltage wave shape is referenced (e.g. a 10/700 open circuit voltage generator typically produces a 5/310 short circuit current). If the combination or circuit defined generators operate into a finite resistance the wave shape produced is intermediate between the open circuit and short circuit values.

## ITU-T 10/700 generator

This circuit defined generator is specified in many standards. The descriptions and values are not consistent between standards and it is important to realise that it is always the same generator being used.

Figure 33 shows the 10/700 generator circuit defined in ITU-T recommendation K.20 (10/96) "Resistibility of telecommunication switching equipment to overvoltages and overcurrents". The basic generator comprises of:

capacitor  $C_1$ , charged to voltage  $V_C$ , which is the energy storage element. switch SW to discharge the capacitor into the output shaping network

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shunt resistor  $R_1$ , series resistor  $R_2$  and shunt capacitor  $C_2$  form the output shaping network. series feed resistor  $R_3$  to connect to one line conductor for single surge series feed resistor  $R_4$  to connect to the other line conductor for dual surging

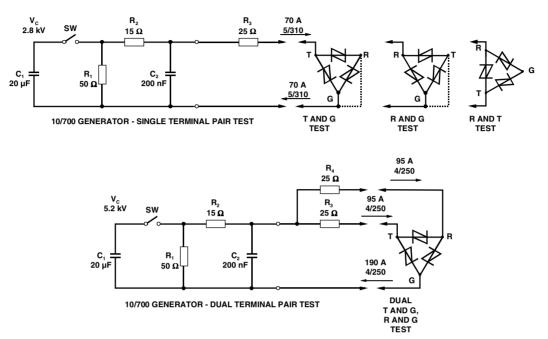


Figure 33.

In the normal single surge equipment test configuration, the unsurged line is grounded. This is shown by the dotted lines in the top drawing of Figure 33. However, doing this at device test places one terminal pair in parallel with another terminal pair. To check the individual terminal pairs of the TISP7xxxF3, without any paralleled operation, the unsurged terminal is left unconnected.

With the generator output open circuit, when SW closes, C1 discharges through  $R_1$ . The decay time constant will be  $C_1R_1$ , or 20 x 50 = 1000  $\mu$ s. For the 50% voltage decay time the time constant needs to be multiplied by 0.697, giving 0.697 x 1000 = 697  $\mu$ s which is rounded to 700  $\mu$ s.

The output rise time is controlled by the time constant of  $R_2$  and  $C_2$ . which is 15 x 200 = 3000 ns or 3  $\mu$ s. Virtual voltage rise times are given by straight line extrapolation through the 30% and 90% points of the voltage waveform to zero and 100%. Mathematically this is equivalent to 3.24 times the time constant, which gives 3.24 x 3 = 9.73 which is rounded to 10  $\mu$ s. Thus the open circuit voltage rises in 10  $\mu$ s and decays in 700  $\mu$ s, giving the 10/700 generator its name.

When the overvoltage protector switches it effectively shorts the generator output via the series 25  $\Omega$  resistor. Two short circuit conditions need to be considered: single output using R<sub>3</sub> only (top circuit of Figure 33) and dual output using R<sub>3</sub> and R<sub>4</sub> (bottom circuit of Figure 33).

For the single test, the series combination of  $R_2$  and  $R_3$  (15 + 25 = 40  $\Omega$ ) is in shunt with  $R_1$ . This lowers the discharge resistance from 50  $\Omega$  to 22.2  $\Omega$ , giving a discharge time constant of 444  $\mu$ s and a 50% current decay time of 309.7  $\mu$ s, which is rounded to 310  $\mu$ s.

For the rise time,  $R_2$  and  $R_3$  are in parallel, reducing the effective source resistance from 15  $\Omega$  to 9.38  $\Omega$ , giving a time constant of 1.88  $\mu$ s. Virtual current rise times are given by straight line extrapolation through the 10% and 90% points of the current waveform to zero and 100%. Mathematically this is equivalent to 2.75



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times the time constant, which gives  $2.75 \times 1.88 = 5.15$ , which is rounded to  $5 \mu s$ . Thus the short circuit current rises in  $5 \mu s$  and decays in  $310 \mu s$ , giving the 5/310 wave shape.

The series resistance from  $C_1$  to the output is 40  $\Omega$  giving an output conductance of 25 A/kV. For each 1 kV of capacitor charge voltage, 25 A of output current will result.

For the dual test, the series combination of  $R_2$  plus  $R_3$  and  $R_4$  in parallel (15 + 12.5 = 27.5  $\Omega$ ) is in shunt with  $R_1$ . This lowers the discharge resistance from 50  $\Omega$  to 17.7  $\Omega$ , giving a discharge time constant of 355  $\mu$ s and a 50% current decay time of 247  $\mu$ s, which is rounded to 250  $\mu$ s.

For the rise time,  $R_2$ ,  $R_3$  and  $R_4$  are in parallel, reducing the effective source resistance from 15  $\Omega$  to 6.82  $\Omega$ , giving a time constant of 1.36  $\mu$ s, which gives a current rise time of 2.75 x 1.36 = 3.75, which is rounded to 4  $\mu$ s. Thus the short circuit current rises in 4  $\mu$ s and decays in 250  $\mu$ s, giving the 4/250 wave shape.

The series resistance from  $C_1$  to an *individual* output is 2 x 27.5 = 55  $\Omega$  giving an output conductance of 18 A/kV. For each 1 kV of capacitor charge voltage, 18 A of output current will result.

At 25 °C these protectors are rated at 70 A for the single terminal pair condition and 95 A for the dual condition (R and G terminals and T and G terminals). In terms of generator voltage, this gives a maximum generator setting of 70 x 40 = 2.8 kV for the single condition and 2 x 95 x 27.5 = 5.2 kV for the dual condition. The higher generator voltage setting for the dual condition is due to the current waveform decay being shorter at 250  $\mu$ s compared to the 310  $\mu$ s value of the single condition.

Other ITU-T recommendations use the 10/700 generator: K.17 (11/88) "Tests on power-fed repeaters using solid-state devices in order to check the arrangements for protection from external interference" and K.21(10/96) "Resistibility of subscriber's terminal to overvoltages and overcurrents", K.30 (03/93) "Positive temperature coefficient (PTC) thermistors".

Several IEC publications use the 10/700 generator, common ones are IEC 6100-4-5 (03/95) "Electromagnetic compatibility (EMC) - Part 4: Testing and measurement techniques - Section 5: Surge immunity test" and IEC 60950 (04/99) "Safety of information technology equipment".

The IEC 60950 10/700 generator is carried through into other "950" derivatives. Europe is harmonised by CENELEC (Comité Européen de Normalization Electro-technique) under EN 60950 (included in the Low Voltage Directive, CE mark). US has UL (Underwriters Laboratories) 1950 and Canada CSA (Canadian Standards Authority) C22.2 No. 950.

FCC Part 68 "Connection of terminal equipment to the telephone network" (47 CFR 68) uses the 10/700 generator for Type B surge testing. Part 68 defines the open circuit voltage wave shape as 9/720 and the short circuit current wave shape as 5/320 for a single output. The current wave shape in the dual (longitudinal) test condition is not defined, but it can be assumed to be 4/250.

Several VDE publications use the 10/700 generator, for example: VDE 0878 Part 200 (12/92) "Electromagnetic compatibility of information technology equipment and telecommunications equipment; Immunity of analogue subscriber equipment".

## 1.2/50 generators

The 1.2/50 open circuit voltage and 8/20 short circuit current combination generator is defined in IEC 61000-4-5 (03/95) "Electromagnetic compatibility (EMC) - Part 4: Testing and measurement techniques - Section 5: Surge immunity test". This generator has a fictive output resistance of 2  $\Omega$ , meaning that dividing the open circuit output voltage by the short circuit output current gives a value of 2  $\Omega$  (500 A/kV).

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The combination generator has three testing configurations; directly applied for testing between equipment a.c. supply connections, applied via an external 10  $\Omega$  resistor for testing between the a.c. supply connections and ground, and applied via an external 40  $\Omega$  resistor for testing all other lines. For unshielded unsymmetrical data or signalling lines, the combination generator is applied via a 40  $\Omega$  resistor either between lines or line to ground. For unshielded symmetrical telecommunication lines, the combination generator is applied to all lines via a resistor of n x 40  $\Omega$ , where n is the number of conductors and the maximum value of external feed resistance is 250  $\Omega$ . Thus for four conductors n = 4 and the series resistance is 4 x 40 = 160  $\Omega$ . For ten conductors the resistance cannot be 10 x 40 = 400  $\Omega$  and must be 250  $\Omega$ . The combination generator is used for short distance lines, long distance lines are tested with the 10/700 generator.

When the combination generator is used with a 40  $\Omega$ , or more, external resistor, the current wave shape is not 8/20, but becomes closer to the open circuit voltage wave shape of 1.2/50. For example, a commercial generator when used with 40  $\Omega$  produced an 1.4/50 wave shape.

The wave shapes of 1.2/50 and 8/20 occur in other generators as well. British Telecommunication has a combination generator with 1.2/50 voltage and 8/20 current wave shapes, but it has a fictive resistance of 1  $\Omega$ . ITU-T recommendation K.22 "Overvoltage resistibility of equipment connected to an ISDN T/S BUS" (05/95) has a 1.2/50 generator option using only resistive and capacitive elements, Figure 34.

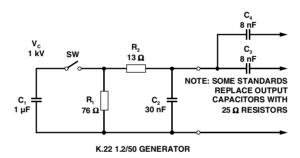


Figure 34.

The K.22 generator produces a 1.4/53 open circuit voltage wave. Using 25  $\Omega$  output resistors, gives a single short circuit current output wave shape of 0.8/18 with 26 A/kV and a dual of 0.6/13 with 20 A/kV. These current wave shapes are often rounded to 1/20 and 0.8/14.

There are 8/20 short circuit current defined generators. These are usually very high current, 10 kA or more and are used for testing a.c. protectors, primary protection modules and some Gas Discharge Tubes.

## impulse testing

To verify the withstand capability and safety of the equipment, standards require that the equipment is tested with various impulse wave forms. The table in this section shows some common test values.

Manufacturers are being increasingly required to design in protection coordination. This means that each protector is operated at its design level and currents are diverted through the appropriate protector e.g. the primary level current through the primary protector and lower levels of current may be diverted through the secondary or inherent equipment protection. Without coordination, primary level currents could pass through the equipment only designed to pass secondary level currents. To ensure coordination happens with fixed voltage protectors, some resistance is normally used between the primary and secondary protection (R1a and R1b Figure 36). The values given in this data sheet apply to a 400 V (d.c. sparkover) gas discharge tube primary protector and the appropriate test voltage when the equipment is tested with a primary protector.



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	PEAK VOLTAGE	VOLTAGE	PEAK CURRENT	CURRENT	TISP7xxxF3	SERIES	COORDINATION
STANDARD	SETTING	WAVE FORM	VALUE	WAVE FORM	25 °C RATING	RESISTANCE	RESISTANCE
	V	μs	Α	μs	Α	Ω	$\Omega$ (MIN.)
GR-1089-CORE	2500	2/10	2 x 500	2/10	2 x 190	12	NA
G11-1009-CO11L	1000	10/1000	2 x 100	10/1000	2 x 45	12	IVA
	1500	10/160	200	10/160	110	6	
FCC Part 68	800	10/560	100	10/560	50	8	
(March 1998)	1000	9/720 †	25	5/320 †	70		NA
(Walch 1990)	1500	(SINGLE)	37.5	5/320 †	70	0	
	1500	(DUAL)	2 x 27	4/250	2 x 95		
I 31-24	1500	0.5/700	37.5	0.2/310	70	0	NA
	1000	10/700	25	5/310	70	0	NA
ITU-T K20/K21	1500	(SINGLE)	37.5	5/310	70	0	NA
110-1 K20/K21	4000	(SINGLE)	100	5/310	70	17	6
	4000	(DUAL)	2 x 72	4/250	2 x 95	0	6

<sup>†</sup> FCC Part 68 terminology for the waveforms produced by the ITU-T recommendation K21 10/700 impulse generator

NA = Not Applicable, primary protection removed or not specified.

If the impulse generator current exceeds the protectors current rating then a series resistance can be used to reduce the current to the protectors rated value and so prevent possible failure. The required value of series resistance for a given waveform is given by the following calculations. First, the minimum total circuit impedance is found by dividing the impulse generators peak voltage by the protectors rated current. The impulse generators fictive impedance (generators peak voltage divided by peak short circuit current) is then subtracted from the minimum total circuit impedance to give the required value of series resistance. In some cases the equipment will require verification over a temperature range. By using the derated waveform values from the thermal information section, the appropriate series resistor value can be calculated for ambient temperatures in the range of 0 °C to 70 °C.

#### protection voltage

The protection voltage,  $(V_{(BO)})$ , increases under lightning surge conditions due to thyristor regeneration. This increase is dependent on the rate of current rise, di/dt, when the TISP<sup>®</sup> is clamping the voltage in its breakdown region. The  $V_{(BO)}$  value under surge conditions can be estimated by multiplying the 50 Hz rate  $V_{(BO)}$  (250 V/ms) value by the normalised increase at the surge's di/dt. An estimate of the di/dt can be made from the surge generator voltage rate of rise, dv/dt, and the circuit resistance.

As an example, the ITU-T recommendation K.21 1.5 kV, 10/700 surge has an average dv/dt of 150 V/ $\mu$ s, but, as the rise is exponential, the initial dv/dt is three times higher, being 450 V/ $\mu$ s. The instantaneous generator output resistance is 25  $\Omega$ . If the equipment has an additional series resistance of 20  $\Omega$ , the total series resistance becomes 45  $\Omega$ . The maximum di/dt then can be estimated as 450/45 = 10 A/ $\mu$ s. In practice the measured di/dt and protection voltage increase will be lower due to inductive effects and the finite slope resistance of the TISP® breakdown region.

## capacitance

## off-state capacitance

The off-state capacitance of a TISP® is sensitive to junction temperature,  $T_J$ , and the bias voltage, comprising of the dc voltage,  $V_D$ , and the ac voltage,  $V_d$ . All the capacitance values in this data sheet are measured with an ac voltage of 1 V rms. When  $V_D >> V_d$  the capacitance value is independent on the value of  $V_d$ . Up to 10 MHz the capacitance is essentially independent of frequency. Above 10 MHz the effective capacitance is strongly dependent on connection inductance. For example, a printed wiring (PW) trace of 10 cm could create a circuit resonance with the device capacitance in the region of 80 MHz.

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## longitudinal balance

Figure 35 shows a three terminal TISP® with its equivalent "delta" capacitance. Each capacitance,  $C_{TG}$ ,  $C_{RG}$  and  $C_{TR}$ , is the true terminal pair capacitance measured with a three terminal or guarded capacitance bridge. If wire R is biased at a larger potential than wire T then  $C_{TG} > C_{RG}$ . Capacitance  $C_{TG}$  is equivalent to a capacitance of  $C_{RG}$  in parallel with the capacitive difference of  $(C_{TG} - C_{RG})$ . The line capacitive unbalance is due to  $(C_{TG} - C_{RG})$  and the capacitance shunting the line is  $C_{TR} + C_{RG}/2$ .

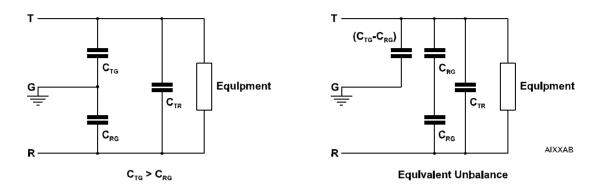


Figure 35.

All capacitance measurements in this data sheet are three terminal guarded to allow the designer to accurately assess capacitive unbalance effects. Simple two terminal capacitance meters (unguarded third terminal) give false readings as the shunt capacitance via the third terminal is included.



## typical circuits

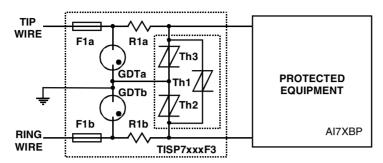


Figure 36. PROTECTION MODULE

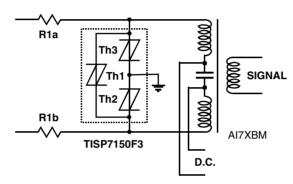


Figure 37. ISDN PROTECTION

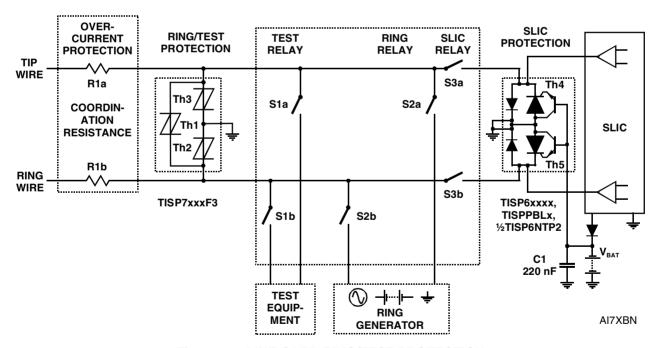


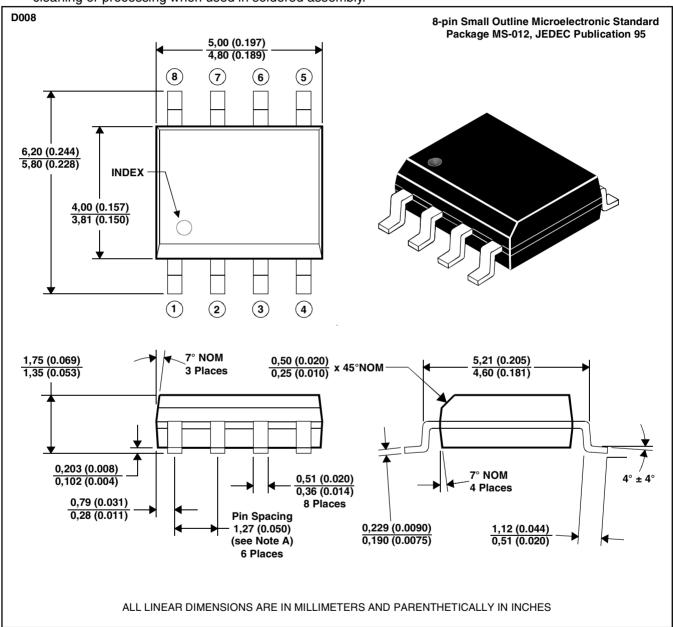
Figure 38. LINE CARD RING/TEST PROTECTION

## **MECHANICAL DATA**

## D008

## plastic small-outline package

This small-outline package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions. Leads require no additional cleaning or processing when used in soldered assembly.



MDXXAAC

NOTES: A. Leads are within 0,25 (0.010) radius of true position at maximum material condition.

- B. Body dimensions do not include mold flash or protrusion.
- C. Mold flash or protrusion shall not exceed 0,15 (0.006).
- D. Lead tips to be planar within  $\pm 0.051$  (0.002).

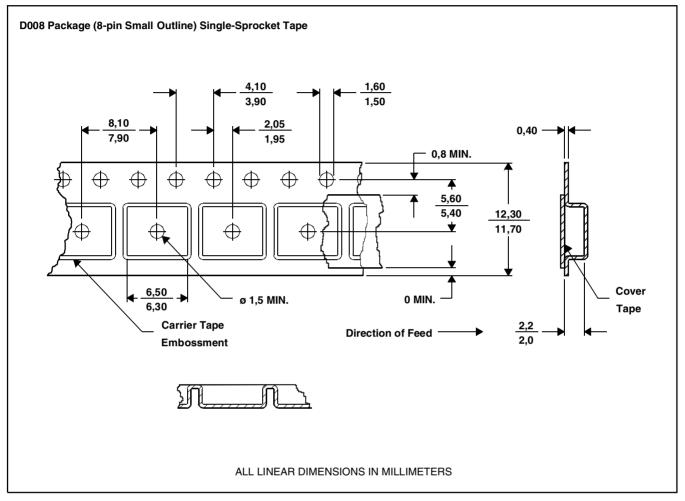


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## **MECHANICAL DATA**

#### D008

## tape dimensions



NOTES: A. Taped devices are supplied on a reel of the following dimensions:-

**MDXXATB** 

Reel diameter: 330 +0.0/-4.0 mmReel hub diameter:  $100 \pm 2.0 \text{ mm}$ Reel axial hole:  $13.0 \pm 0.2 \text{ mm}$ 

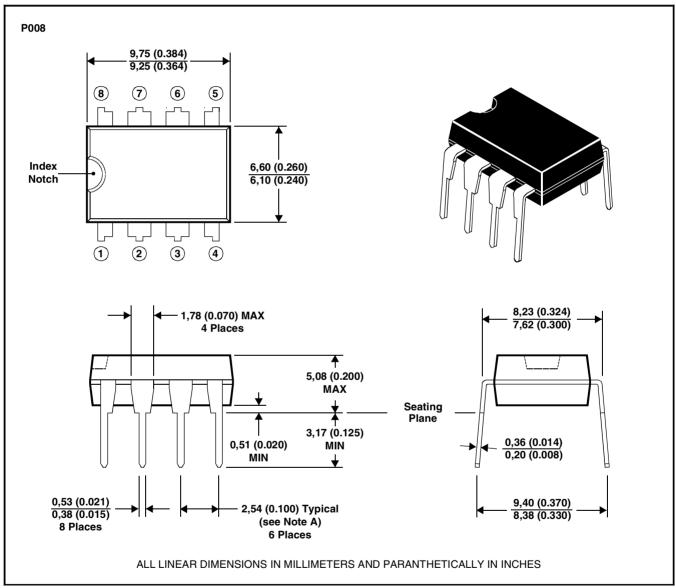
B. 2500 devices are on a reel.

## **MECHANICAL DATA**

## P008

## plastic dual-in-line package

This dual-in-line package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions The package is intended for insertion in mounting-hole rows on 7,62 (0.300) centres. Once the leads are compressed and inserted, sufficient tension is provided to secure the package in the board during soldering. Leads require no additional cleaning or processing when used in soldered assembly.



MDXXCF

NOTES: A. Each pin centreline is located within 0,25 (0.010) of its true longitudinal position.

- B. Dimensions fall within JEDEC MS001 R-PDIP-T, 0.300" Dual-In-Line Plastic Family.
- C. Details of the previous dot index P008 package style, drawing reference MDXXABA, are given in the earlier publications.

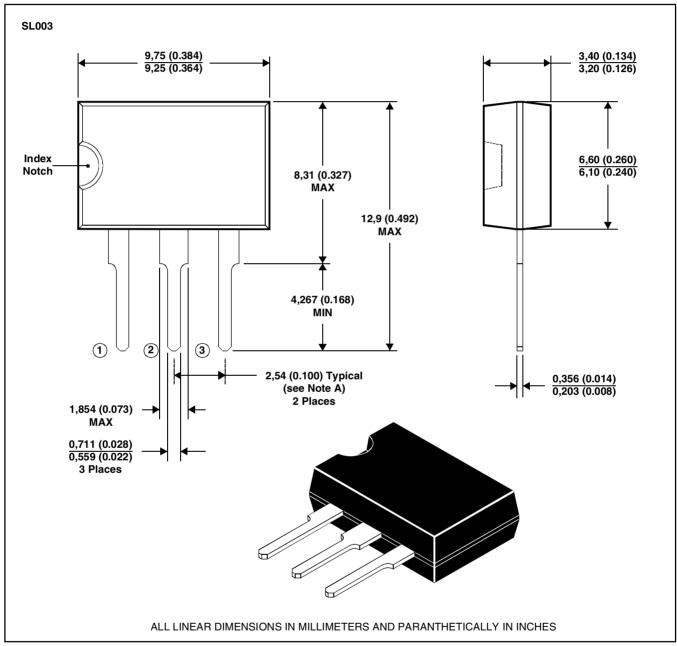


## **MECHANICAL DATA**

#### **SL003**

## 3-pin plastic single-in-line package

This single-in-line package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions. Leads require no additional cleaning or processing when used in soldered assembly.



MDXXCE

- NOTES: A. Each pin centreline is located within 0,25 (0.010) of its true longitudinal position.
  - B. Body molding flash of up to 0,15 (0.006) may occur in the package lead plane.
  - C. Details of the previous dot index SL003 style, drawing reference MDXXAD, are given in the earlier publications.

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